# DATA SHEET

# PHOTOCOUPLER PS2702-1,PS2702-2,PS2702-4

# HIGH ISOLATION VOLTAGE DARLINGTON TRANSISTOR SOP MULTI PHOTOCOUPLER SERIES -NEPOC<sup>™</sup> Series-

#### DESCRIPTION

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The PS2702-1, PS2702-2, PS2702-4, are optically coupled isolators containing a GaAs light emitting diode and an NPN silicon darlington-connected phototransistor.

Each is mounted in a plastic SOP (Small Out-line Package) for high density applications.

This package has shield effect to cut off ambient light.

#### FEATURES

- High current transfer ratio (CTR = 2 000 % TYP.)
- High isolation voltage (BV = 3 750 Vr.m.s.)
- Small and thin (SOP) package
- High-speed switching (tr, tr = 200  $\mu$ s TYP.)
- Ordering number of taping product (1-ch only): PS2702-1-E3, E4, F3, F4
- UL approved: File No. E72422 (S)
- VDE0884 approved (Option)

#### **APPLICATIONS**

- Hybrid IC
- ★ Telephone/FAX
- ★ FA/OA equipment
  - Programmable logic controllers

#### ORDERING INFORMATION

Part Number	Package	Safety Standard Approval
PS2702-1	4-pin SOP	Standard specification products
PS2702-2	8-pin SOP	• UL approved
PS2702-4	16-pin SOP	
PS2702-1-V	4-pin SOP	VDE0884 specification products (Option)
PS2702-2-V	8-pin SOP	
PS2702-4-V	16-pin SOP	

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#### PACKAGE DIMENSIONS (in millimeters)



Parameter		Symbol	Ratings			
			PS2702-1	PS2702-2, PS2702-4	Unit	
Diode	Forward Current (DC)	lF	50		mA	
	Reverse Voltage	VR	6.0		V	
	Power Dissipation Derating	⊿P <sub>D</sub> /°C	0.8		mW/°C	
	Power Dissipation	PD	80		mW/ch	
	Peak Forward Current <sup>*1</sup>	IFP	1		А	
Transistor	Collector to Emitter Voltage	Vceo	40		V	
	Emitter to Collector Voltage	Veco	6		V	
	Collector Current	lc	200	160	mA/ch	
	Power Dissipation Derating	⊿Pc/°C	1.5	1.2	mW/°C	
	Power Dissipation	Pc	150	120	mW/ch	
Isolation Vo	bltage <sup>*2</sup>	BV	3 750		Vr.m.s.	
Operating Ambient Temperature		TA	–55 to +100		°C	
Storage Temperature		Tstg	–55 to +150		°C	

## ABSOLUTE MAXIMUM RATINGS (TA = 25 °C, unless otherwise specified)

\*1 PW = 100  $\mu$ s, Duty Cycle = 1 %

\*2 AC voltage for 1 minute at  $T_A = 25$  °C, RH = 60 % between input and output

	Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Diode	Forward Voltage	VF	IF = 5 mA		1.1	1.4	V
	Reverse Current	Ir	V <sub>R</sub> = 5 V			5	μA
	Terminal Capacitance	Ct	V = 0 V, f = 1 MHz		30		pF
Transistor	Collector to Emitter Current	ICEO	IF = 0 mA, Vce = 40 V			400	nA
Coupled	Current Transfer Ratio (Ic/IF) <sup>*1</sup>	CTR	IF = 1 mA, VcE = 2 V	200	2 000		%
	Collector Saturation Voltage	VCE (sat)	I⊧ = 1 mA, Ic = 2 mA			1.0	V
	Isolation Resistance	Ri-o	VI-O = 1 kVDC	10 <sup>11</sup>			Ω
	Isolation Capacitance	CI-O	V = 0 V, f = 1 MHz		0.4		pF
	Rise Time <sup>*2</sup>	tr	$V_{CC} = 5 \text{ V}, \text{ Ic} = 2 \text{ mA}, \text{ R}_{L} = 100 \Omega$		200		μs
	Fall Time <sup>*2</sup>	tr			200		

#### ELECTRICAL CHARACTERISTICS (TA = 25 °C)

\*1 CTR rank (only PS2702-1)

K: 2 000 to (%)

L: 700 to 3 400 (%)

M: 200 to 1 000 (%)

\* \*2 Test circuit for switching time



#### TYPICAL CHARACTERISTICS (TA = 25 °C, unless otherwise specified)



Ambient Temperature TA (°C)



50

Ambient Temperature T<sub>A</sub> (°C)

COLLECTOR TO EMITTER VOLTAGE

75

100

0

180 160

140

120

100

80

60

40

20

0

lc (mA)

Collector Current

25

COLLECTOR CURRENT vs.

IF = 5 mA

2 mA

0.5 mA

4

2

TRANSISTOR POWER DISSIPATION vs.

COLLECTOR CURRENT vs. COLLECTOR SATURATION VOLTAGE

Collector to Emitter Voltage VCE (V)

6

8

10







CURRENT TRANSFER RATIO vs. FORWARD CURRENT



FREQUENCY RESPONSE



LONG TERM CTR DEGRADATION 1.2**[** ~ CTR Degradation (Relative Value) 1.0 0.8 I<sub>F</sub> = 1 mA, T<sub>A</sub> = 25 °C  $I_F = 1 \text{ mA}, \text{ } T_A = 60 \text{ }^\circ\text{C}$ 0.6 0.4 0.2 0.0L 10<sup>2</sup> 10<sup>3</sup> 10<sup>4</sup> 10<sup>5</sup> 10<sup>6</sup> Time (Hr)

Remark The graphs indicate nominal characteristics.

#### **TAPING SPECIFICATIONS (in millimeters)**



#### **RECOMMENDED SOLDERING CONDITIONS**

#### (1) Infrared reflow soldering

- Peak reflow temperature
  235 °C (package surface temperature)
- Time of temperature higher than 210 °C
- Number of reflows
- Flux

Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of 0.2 Wt % is recommended.)

#### Recommended Temperature Profile of Infrared Reflow

30 seconds or less

Three



#### (2) Dip soldering

- Temperature 260 °C or below (molten solder temperature)
- Time
- 10 seconds or less
- Number of times One
- Flux

Rosin flux containing small amount of chlorine (The flux with a maximum chlorine content of 0.2 Wt % is recommended.)

#### (3) Cautions

+

Fluxes

Avoid removing the residual flux with freon-based and chlorine-based cleaning solvent.

## SPECIFICATION OF VDE MARKS LICENSE DOCUMENT (VDE0884)

Parameter	Symbol	Speck	Unit
Application classification (DIN VDE 0109) for rated line voltages $\leq$ 300 Vr.m.s. for rated line voltages $\leq$ 600 Vr.m.s.		IV III	
Climatic test class (DIN IEC 68 Teil 1/09.80)		55/100/21	
Dielectric strength maximum operating isolation voltage Test voltage (partial discharge test, procedure a for type test and random test) $U_{pr} = 1.2 \times U_{IORM}, P_d < 5 pC$	Uiorm Upr	710 850	V <sub>peak</sub> V <sub>peak</sub>
Test voltage (partial discharge test, procedure b for random test) $U_{\text{pr}}$ = 1.6 $\times$ U_{IORM}, P_{d} < 5 pC	Upr	1 140	V <sub>peak</sub>
Highest permissible overvoltage	Utr	6 000	Vpeak
Degree of pollution (DIN VDE 0109)		2	
Clearance distance		> 5	mm
Creepage distance		> 5	mm
Comparative tracking index (DIN IEC 112/VDE 0303 part 1)	CTI	175	
Material group (DIN VDE 0109)		lli a	
Storage temperature range	Tstg	-55 to +150	°C
Operating temperature range	TA	-55 to +100	°C
Isolation resistance, minimum value $V_{IO} = 500 \text{ V dc at } T_A = 25 ^{\circ}\text{C}$ $V_{IO} = 500 \text{ V dc at } T_A \text{ MAX. at least } 100 ^{\circ}\text{C}$	Ris MIN. Ris MIN.	10 <sup>12</sup> 10 <sup>11</sup>	Ω Ω
Safety maximum ratings (maximum permissible in case of fault, see thermal derating curve) Package temperature Current (input current IF, Psi = 0) Power (output or total power dissipation) Isolation resistance	Tsi Isi Psi	150 200 300	°C mA mW
$V_{IO}$ = 500 V dc at T <sub>A</sub> = 175 °C (Tsi)	Ris MIN.	10 <sup>°</sup>	Ω

[MEMO]

## CAUTION

Within this device there exists GaAs (Gallium Arsenide) material which is a harmful substance if ingested. Please do not under any circumstances break the hermetic seal.

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